

HARVARD & SMITHSONIAN

The Chandra Source Catalog 2.0

F. Civano (CfA/CXC)

On behalf of the Chandra Source Catalog team

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CHANDRA

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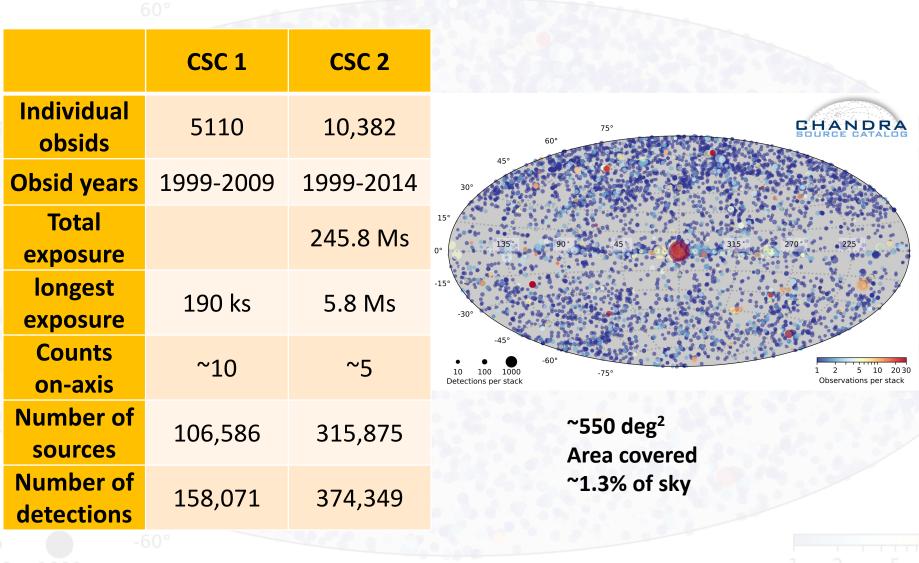
Observations p

MIT KAVI

INSTITUTE

-75

CSC 2.0 in numbers



100 1000 ons per stack

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Observations |

CSC 2.0 features



Source detection on stacked observations

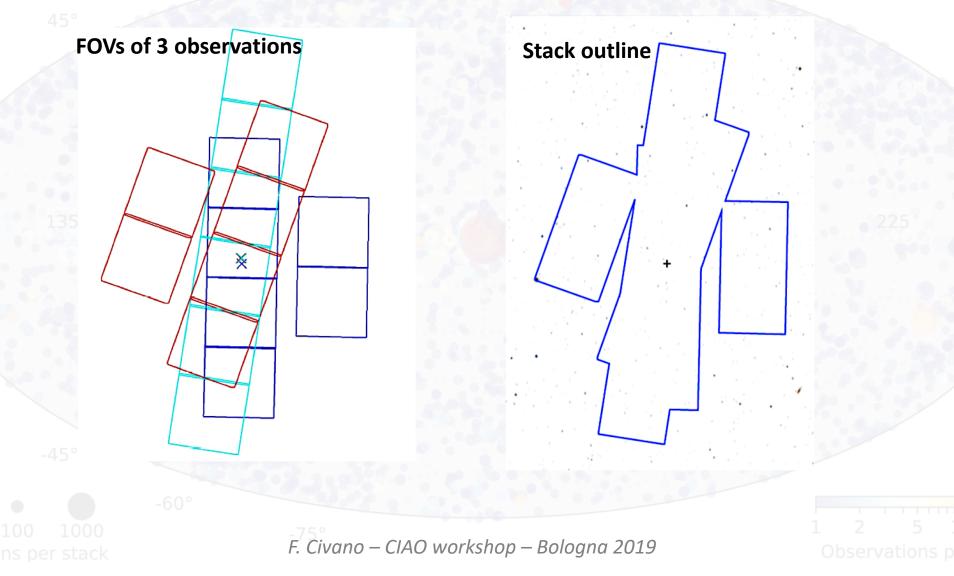
• -6 100 1000 ons per stack

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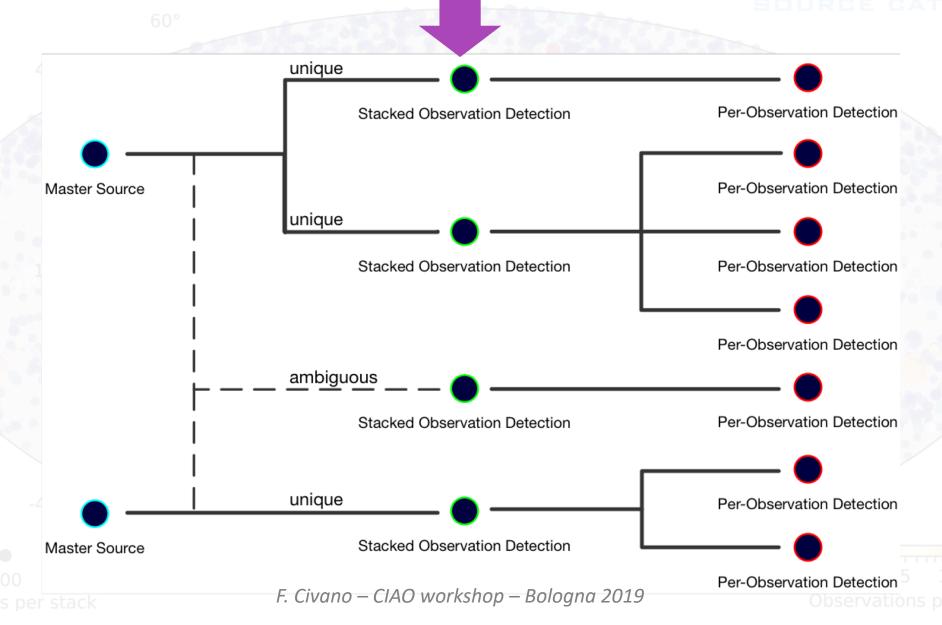
L 2 5 C Observations p

Stacked observations

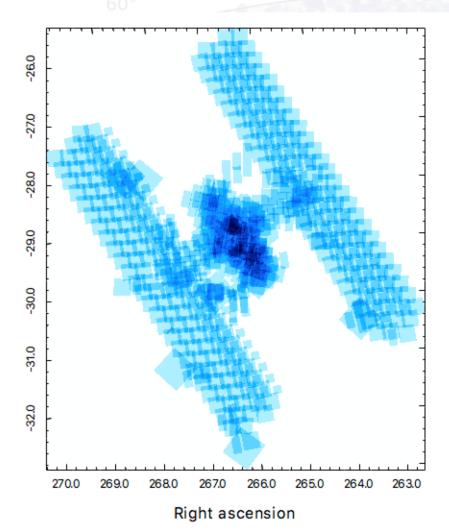
STACKS: sum of observations with pointings within 1' to increase sensitivity



Source detection hierarchy



Example: Galactic Center Area



- 534 single *Chandra* observations
- 379 stacks (36 HRC and 343 ACIS)
- Total area covered ~ 19 deg²
- Total exposure time ~ 9 Ms

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Observations p

Declination

Example: Galactic Center Area

Sgr A* - central stack of 71 observations



100 1000 ons per stack

CSC 2.0 features

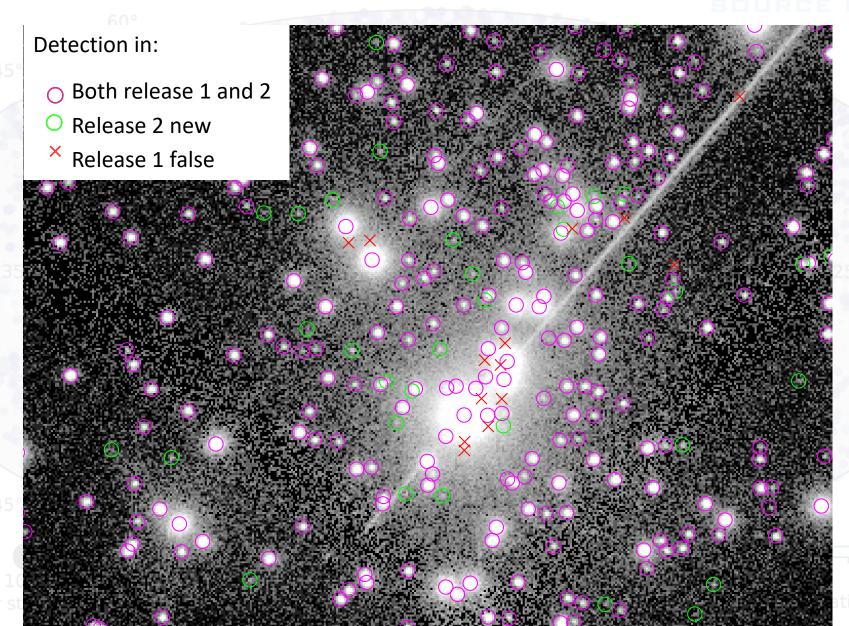


- Source detection on stacked observations
- New source detection approach
 - Wavelet detection *plus* Voronoi tessellation algorithm
 - Maximum likelihood estimator to improve on-axis detection (~5 net counts for exposures < 15 ks)

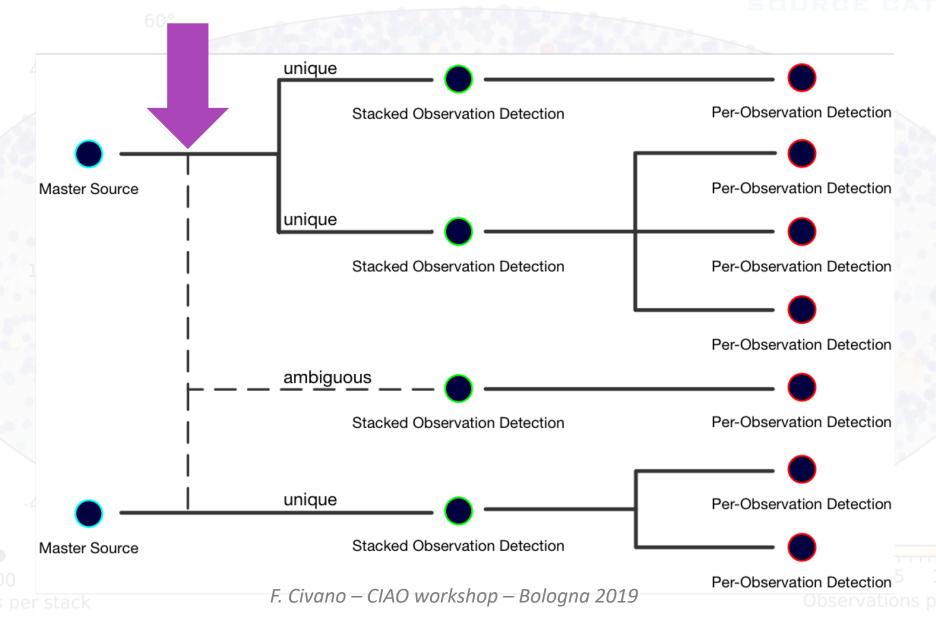
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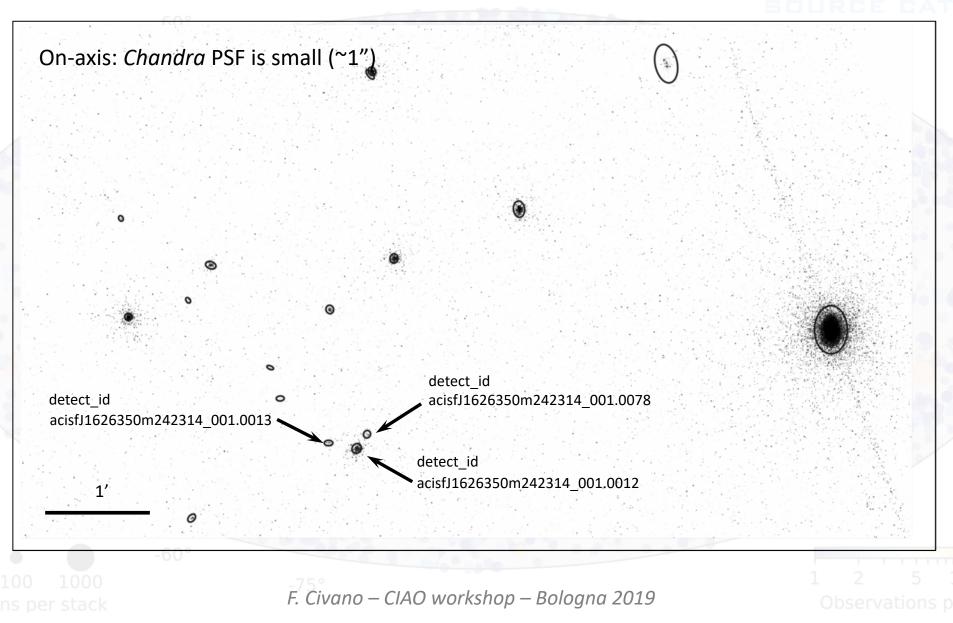
Detection: reaching the faintest sources



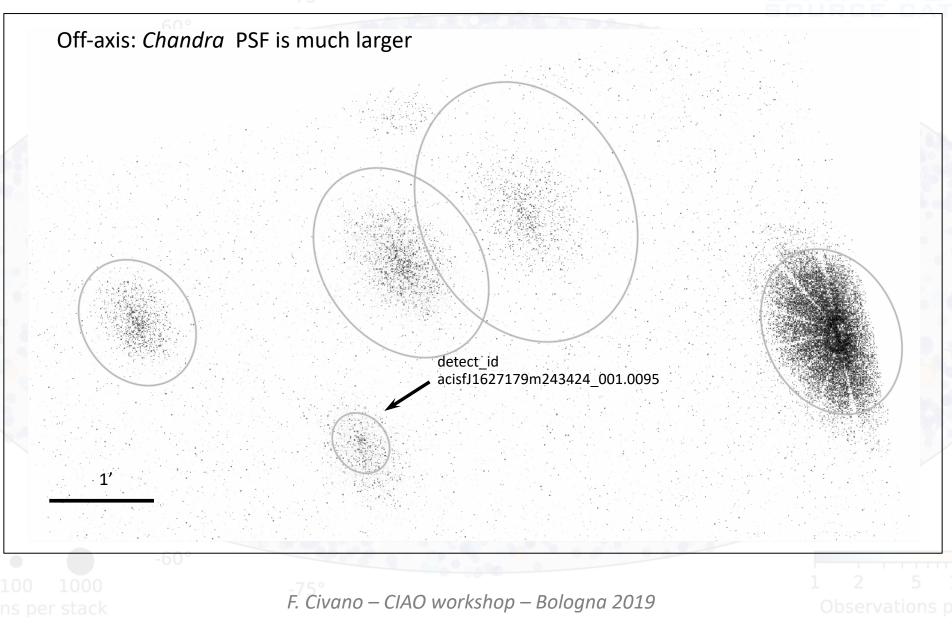
Master matching process



Detections and sources



Detections and sources



Detections and sources

Multiple sources on-axis may be **CONFUSED** in off-axis observations of the same field

The catalog reconciles detections at different off-axis angles

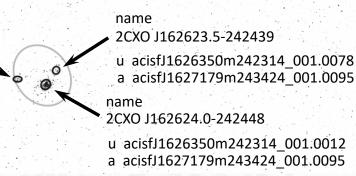
2CXO J162625.3-242444

name

1'

u acisfJ1626350m242314 001.0013

a acisfJ1627179m243424 001.0095



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L 2 5 Observations p

CSC 2.0 features



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- MCMC draws provide relative astrometry position error ellipses

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CSC 2.0 features



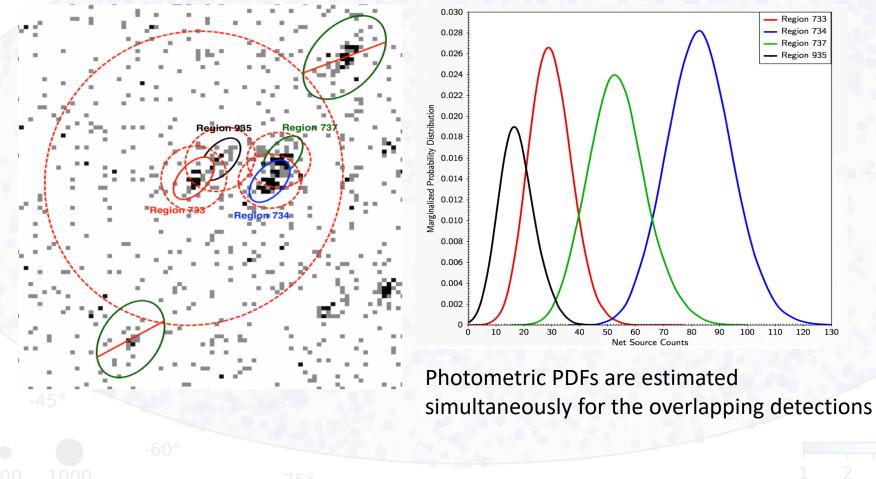
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- Aperture photometry; multi-band Bayesian Blocks algorithm

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Source Properties: Aperture Photometry

Fluxes are measured in each observation: Bayesian approach for simultaneous aperture photometry estimation in crowded fields (*Primini, F. A. & Kashyap, V. L. 2014*)



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Source Properties: Aperture Photometry

Bayesian Model

Analyze sources with overlapping apertures, near-by sources, and background simultaneously.

Joint posterior for source fluxes and background flux (for single observation):

$$P(s_1 \dots s_n, b | C_1 \dots C_n, B) = K \times P(b) P_{Pois}(B | \phi) \prod P(s_i) P_{Pois}(C_i | \theta_i)$$
$$\theta_i = E_i \times \left[\sum_{j=1}^n f_{ij} s_j + \Omega_i b \right]; \phi = E_b \times \left[\sum_{i=1}^n g_i s_i + \Omega_b b \right]$$

Counts in overlpaping regions assigned to brightest source

Master source flux for source s_k in an n-source bundle is determined from the Bayesian block for that source with the largest exposure. In this case:

$$P(s_k | \{C_i^j\}, \{B^j\}) \cong P(s_k) \prod_{j=1}^m \left[P_{Pois}(B^j | \hat{\phi}^j) \times P_{Pois}(C_k^j | \hat{\theta}_k^j) \prod_{i=1, i \neq k}^n P_{Pois}(C_i^j | \hat{\theta}_i^j) \right]$$

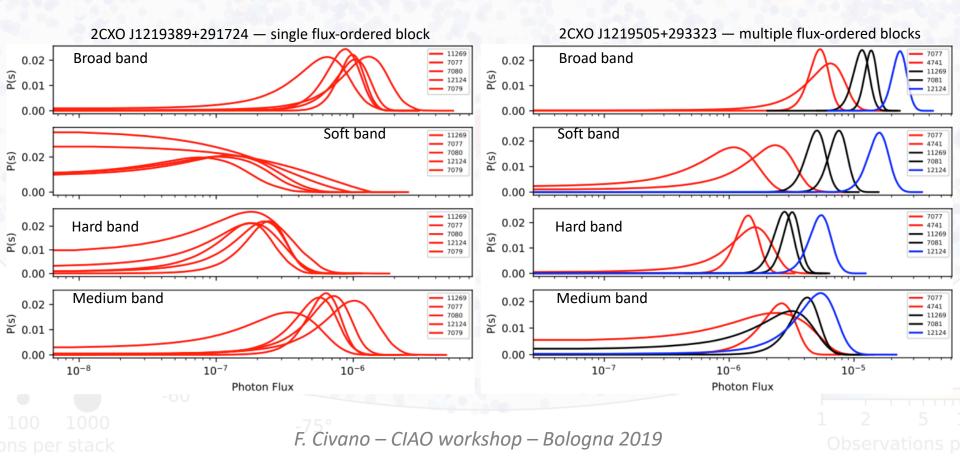
In all cases, a marginalized posterior is obtained for each source are obtained by integration over all other sources and background.

Posteriors optimized and sampled using MCMC in Sherpa.

Observations |

Grouping Observations to Improve S/N

- Multi-band Bayesian Blocks analysis (Scargle+2013) on detection fluxes to identify observations that can be analyzed/grouped together
- The combined properties for the longest exposure Bayesian Block are databased, but the properties for *all* blocks are recorded in a FITS data product

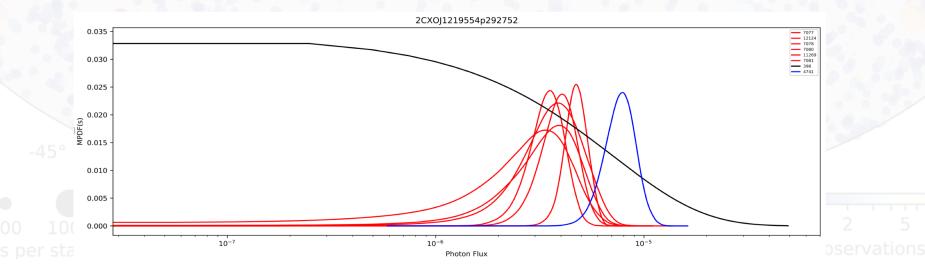


Grouping Observations to Improve S/N

Multi-band Bayesian Blocks analysis (Scargle+2013) on detection fluxes to identify observations that can be analyzed/grouped together The combined properties for the langest expective Revealer Plack are detabased but master level fluxes --> the best flux block determined in the Bayesian Blocks analysis cks 7077 0.02 4741 (s) 0.01 11269 7081 12124 0.00 Soft band Soft band 0.02 7077 4741 11269 7080 (s) B 0.01 (s) 0.02 12124 - 7081 7079 12124 0.00 0.00 11269 0.02 Hard band Hard band 0.02 7077 4741 (s) B 0.02 11269 7080 (s) 0.01 12124 - 7081 7079 12124 0.00 0.00 Medium band Medium band 0.02 0.02 7077 4741 (s) B 0.01 7080 11269 ິສ 0.01 12124 7081 7079 12124 0.00 -0.00 10^{-6} 10-8 10^{-7} 10^{-7} 10^{-6} 10^{-5} Photon Flux Photon Flux F. Civano – CIAO workshop – Bologna 2019

Temporal Variability

- Single observation: Gregory-Loredo Test: Hypothesis rejection test (i.e., odds ratio of assuming variability vs not assuming it). The probability that events detected are not arriving at a uniform rate. Used to estimate intra-obs variability (pick max prob among stack obsids).
- Multiple observations: Inter-observation variability. Variability test is based on a likelihood ratio between the null hypothesis of no variability, and the assumption of variability, when several observations are considered.



CSC 2.0 features



- Source detection on stacked observations
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- MCMC draws provide relative astrometry position error *ellipses*
- Aperture photometry; multi-band Bayesian Blocks algorithm
- Multi-band limiting sensitivity computed on 4" x 4" pixels



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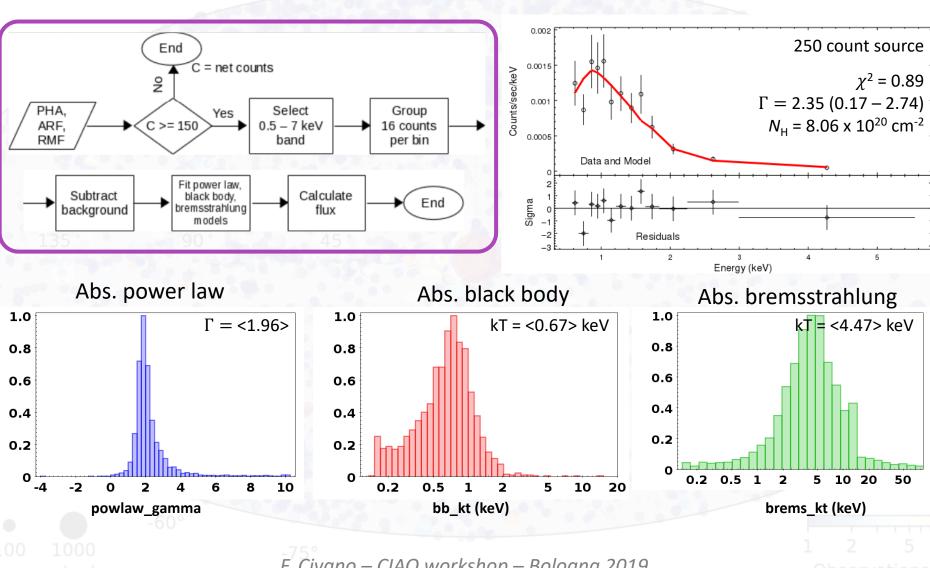
CSC 2.0 new features

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- Aperture photometry; multi-band Bayesian Blocks algorithm
- Multi-band limiting sensitivity computed on 4" x 4" pixels
- Spectra extraction of ALL DETECTIONS and spectral analysis

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Observations p

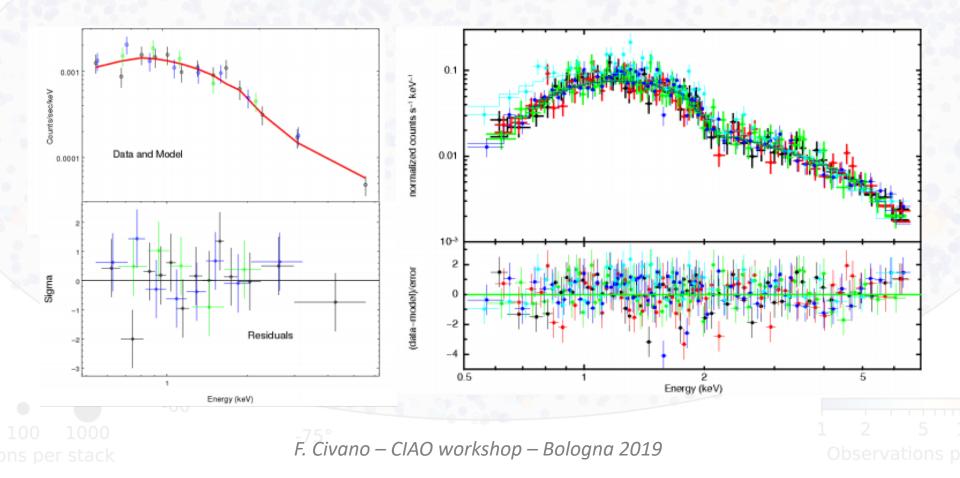
Spectral Analysis



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Joint Spectral Fits

- Sources that are observed multiple times are grouped by the Bayesian blocks analysis
 - All spectra in the block are simultaneously fit



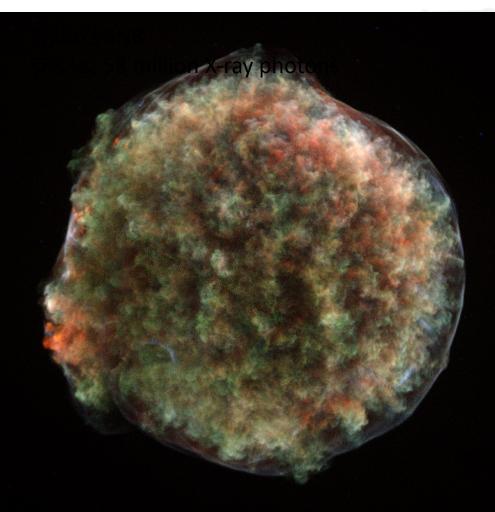
CSC 2.0 features



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- MCMC draws provide relative astrometry position error *ellipses*
- Aperture photometry; multi-band Bayesian Blocks algorithm
- Multi-band limiting sensitivity computed on 4" x 4" pixels
- Spectra extraction and spectral analysis
- Extended emission properties

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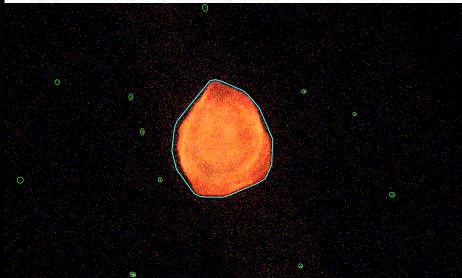
Extended emissions



- SNRs, cluster of galaxies, extended galaxies, jets, etc.

- Photometric properties are integrated over a convex hull bounding region aperture (cyan below).

- Fluxes and regions are going to be provided.



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Databased properties

Master Source Properties

Source name, position and position errors, significance, source flags, multi-band deconvolved extent, multi-band aperture photometry (photon and energy fluxes, spectral model fluxes [multiple spectral models]), hardness ratios, spectral model fits [multiple spectral models], multi-band intra- and interobservation temporal variability

Stacked-Observation Detection Properties

 Position and position errors, multi-band significance, detection flags and codes, multi-band deconvolved extent, multi-band aperture photometry (net counts and count rates, photon and energy fluxes), aperture parameters, hardness ratios, multi-band intra- and inter-observation temporal variability

Per-Observation Detection Properties

 Detector position, multi-band significance, detection flags and codes, multi-band raw, PSF, and deconvolved extent, multi-band aperture photometry (total counts, net counts and count rates, photon and energy fluxes, spectral model fluxes [multiple spectral models]), masked aperture parameters, spectral model fits [multiple spectral models], multi-band intra-observation temporal variability

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Science-Ready FITS Data Products

~25 million files, ~32 TB

Observation Data Products

- Observation event list, aspect solution and histogram, bad pixel map, FoV, pixel mask
- Multi-band images, background images, exposure maps

Stacked-Observation Data Products

- Stack event list, FoV, merged detection list
- Multi-band images, background images, exposure maps, limiting sensitivity

Detection Region Data Products

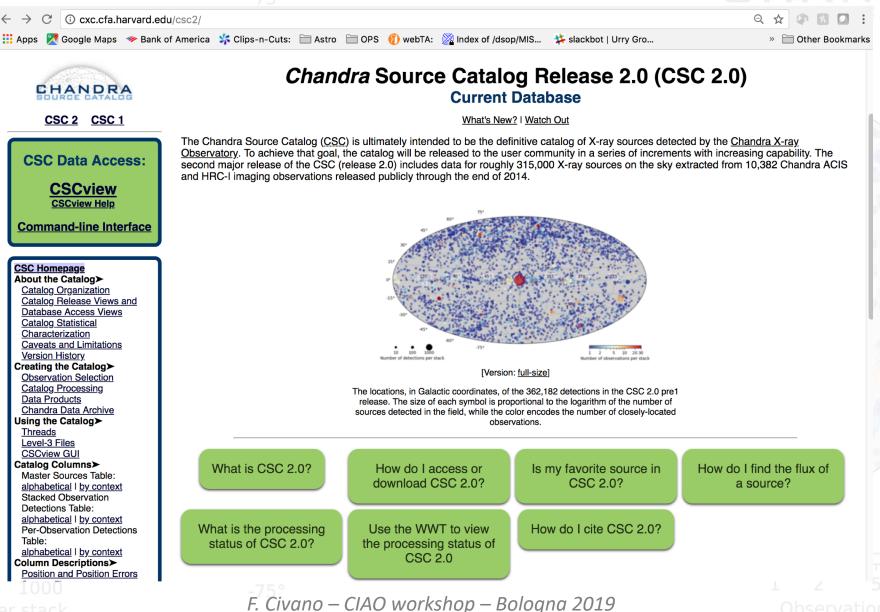
- Detection region stack and observation region definitions, event lists
- Multi-band per-stack and per-observation images, exposure maps, position error MCMC draws, aperture photometry PDFs
- Multi-band per-observation PSFs, light curves
- Per-observation PHA spectrum, RMF, ARF

Source Level Data Products

• Aperture photometry PDFs, per-Bayesian block properties (aperture photometry fluxes, model energy fluxes, spectral fits, hardness ratios)

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For a quick view: WWTCHAND

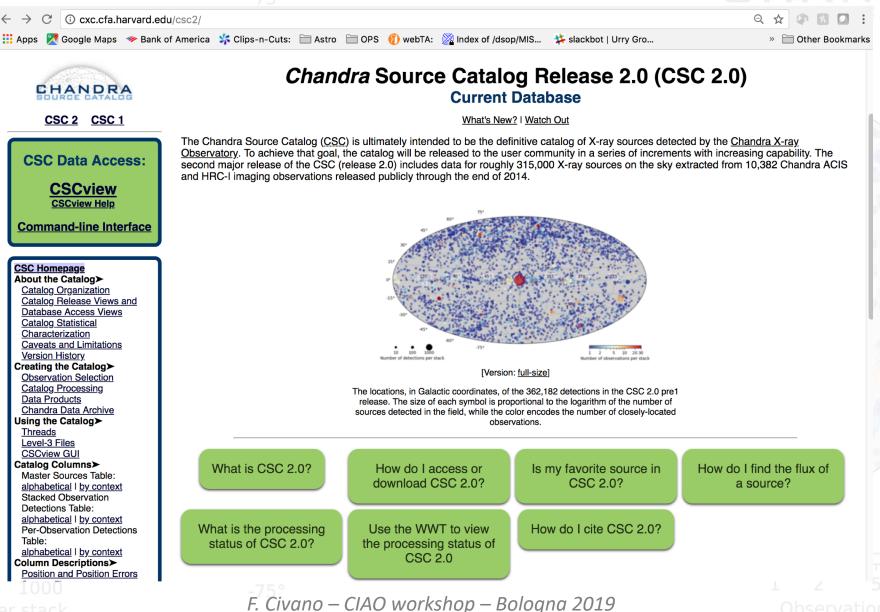
CXC HOME PROPOSER ARCHIVE DATA ANALYSIS INSTRUMENTS & CALIBRATION FOR THE PUBL



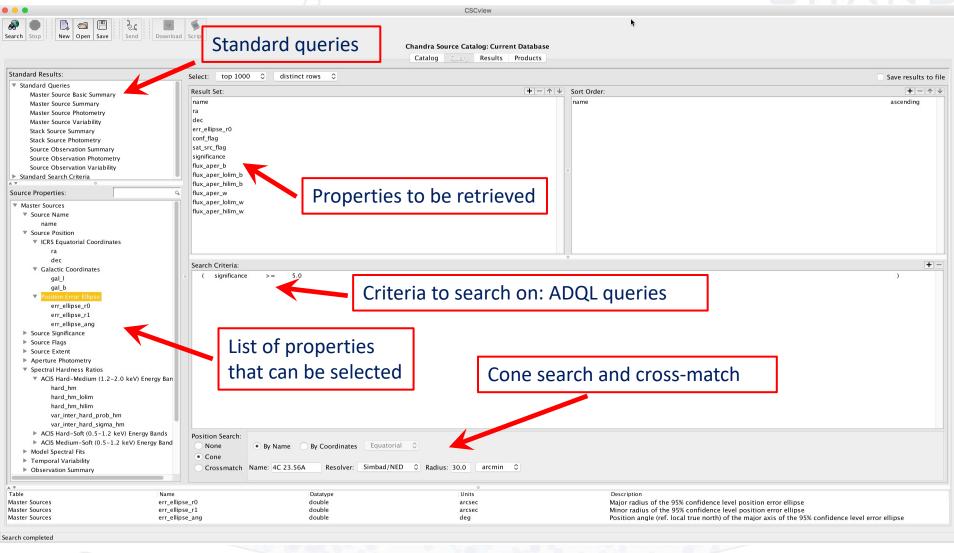
CHANDRA SOURCE CATALOG 2.0			- The set	Source: 2CXO J055033.8-682416	/ / /×
CHANDRA				Copy source name to clipboard Search nearby	: <u>NED</u> or <u>SIMBAD</u> Zoom to source
Sources: 315880 (100.0%)				α: 5 ^h 50 ^m 33.83 ^s δ: -68° 24' 16.8" (ICR	S) 🔶
Select nearest source				<u>95% confidence position error ellipse</u> Galactic n _H column density	1.29" by 0.56" at 129° 6.59 × 10²º cm²
Enter Name or Positi				Aperture-corrected flux (broad band)	7.964e-16 erg cm ⁻² s ⁻¹
Optical (DSS)				Lower confidence limit Upper confidence limit	2.172e-16 1.376e-15
Show Popular Places				<u>Source significance (S/N)</u>	2.61
Hide Stack Outlines		自國	and the second	<u>Hard/Medium band hardness ratio</u> Lower confidence limit	0.075 -0.3467
Hide CSC 2.0 Sources				Upper confidence limit	0.4329
Load XMM Sources		مر	in the second second	Medium/Soft band hardness ratio Lower confidence limit	-0.0412 -0.4029
			-	Upper confidence limit	-0.4029 0.3929
Show Milky Way outline				Number of ACIS observations	1
Full screen Hide banners			A A	Number of HRC observations	U
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Data Retrieval: CSCView



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Data Retrieval: CSCView



CSCview

Chandra Source Catalog: Current Database

Products

Catalog Query

Retrieved tabular properties

ata Products:	Sel	lect all										105 of 1 row	v matched, 52 row	ws retur
Region:	Select		ra	dec	err ellipse r0	err ellipse rJ	1 err_ellipse_ang	conf flar	a sat src f	g significance	e flux aper b		flux aper hilim b	
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Stack Source Region Exposure Map		2CXO J210652.8+232718	8 21 06 52.81	1 +23 27 18.55	5 1.09	0.88	8 105.4	4 TRUE		8.31	31 1.442e-14	4 1.195e-14	4 1.675e-14	4 8.7
Stack Source Region		2CXO J210653.3+233327 2CXO J210654.4+232657							FALSE FALSE	10.25 6.81				
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Valid Stack Source Region Aperture Photometry PDF		2CXO J210656.1+233221	1 21 06 56.12	2 +23 32 21.13	3 0.50	0.50	0.0		FALSE	7.67	57 1.036e-14	4 8.883e-15	5 1.175e-14	L4 7.3
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✓ Event List		2CXO J210658.0+233110 2CXO J210659.5+232907								5.50 5.20				
	a 6	2CXO J210039.3+232907 2CXO J210700.3+233152						RUE	FALSE	8.84				
☐ Image		2CXO J210701.2+233153	3 21 07 01.21	1 +23 31 53.00	0 0.47	7 0.41	1 104.0	D KUE	FALSE	6.87	6.232e-15	5 5.290e-15	5 7.175e-15	15 5.
✓ Point Spread Function		2CXO J210703.1+233022							FALSE	19.77 5.79				
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✓ Source Region		2CXO J210715.1+233315						4 FALSE	FALSE	12.87				
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		2CXO J210735.6+233502							FALSE	6.76				
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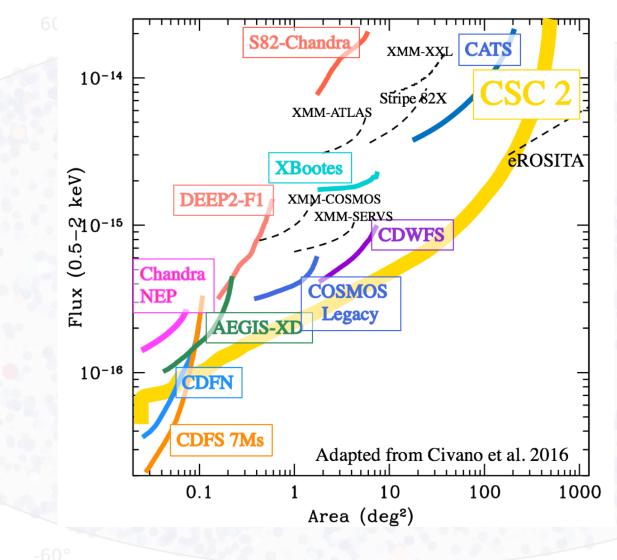
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THANKS

1 2 5 Observations r

CSC 2.0 as a survey



~550 deg² Area covered

225

100 1000 ons per stack

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1 2 5 Observations p

CSC 2.0 as a survey

